

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination OHGISHI, YUKO,	
		Examiner Bradley K. Smith	Art Unit 2891	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0151099 A1	08-2003	Yoshiyama et al.	257/392
*	B	US-2003/0146479 A1	08-2003	Barnak et al.	257/412
*	C	US-2002/0072182 A1	06-2002	Ha et al.	438/301
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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